TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOS IV)

TPC8027

Lithium Ion Battery Applications
Portable Equipment Applications
Notebook PC Applications

· Small footprint due to small and thin package

• Low drain-source ON resistance: $RDS(ON) = 2.1 \text{ m}\Omega$ (typ.)

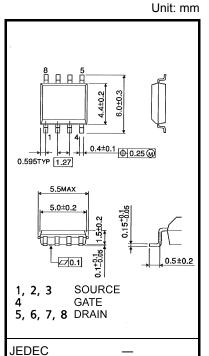
• High forward transfer admittance: $|Y_{fs}| = 48 \text{ S (typ.)}$

• Low leakage current: $IDSS = 10 \mu A (max) (VDS = 30 V)$

• Enhancement mode: $V_{th} = 1.3$ to 2.5 V ($V_{DS} = 10$ V, $I_{D} = 1$ mA)

Absolute Maximum Ratings (Ta = 25°C)

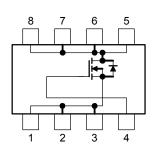
Characte	ristics	Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	30	V
Drain-gate voltage (R	i _{GS} = 20 kΩ)	V_{DGR}	30	V
Gate-source voltage		V _{GSS}	±20	V
Drain current	DC (Note 1)	ID	18	Α
Drain current	Pulse (Note 1)	I _{DP}	72	A
Drain power dissipation	on (t = 10 s) (Note 2a)	P _D	1.9	W
Drain power dissipation	on (t = 10 s) (Note 2b)	P _D	1.0	W
Single pulse avalanch	ne energy (Note 3)	E _{AS}	84	mJ
Avalanche current		I _{AR}	18	Α
Repetitive avalanche	energy Note 2a) (Note 4)	E _{AR}	0.029	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature	range	T _{stg}	-55 to 150	°C



Weight: 0.08 g (typ.)

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Circuit Configuration



2-6J1B

Note 1, Note 2, Note 3 and Note 4: See the next page.

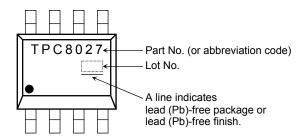
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Please handle with caution.

Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R _{th (ch-a)}	65.8	°C/W	
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-a)}	125	°C/W	

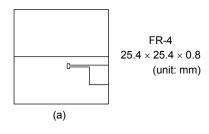
Marking (Note 5)

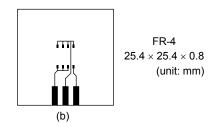


Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)





Note 3: $V_{DD} = 24 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = 0.2 mH, $I_{AR} = 18 \text{ A}$

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: • on lower left of the marking indicates Pin 1.



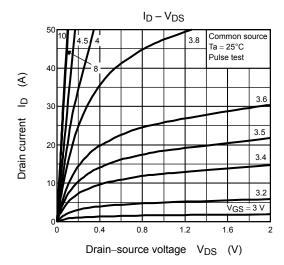
Electrical Characteristics (Ta = 25°C)

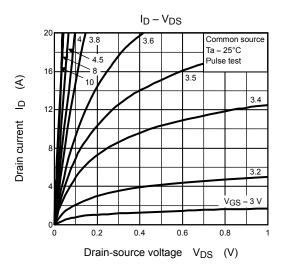
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA
Drain cut-OFF cu	ırrent	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V	_	_	10	μА
Drain-source bre	akdown voltago	V _{(BR) DSS}	$I_D = 10$ mA, $V_{GS} = 0$ V	30	_	_	V
Diain-source bre	akdowii vollage	V _{(BR)DSX}	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	10	_		٧
Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	1.3 — 2.5 — 3.5 5.5 — 2.1 2.7		٧	
		R _{DS} (ON)	$V_{GS} = 4.5 \text{ V}, I_D = 9 \text{ A}$	_	3.5	5.5	mΩ
Dialii-source ON	rain-source ON resistance		$V_{GS} = 10 \text{ V}, I_D = 9 \text{ A}$	_	2.1	2.7	
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, I_D = 9 \text{ A}$	24	48		S
Input capacitance		C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	4200	_	pF
Reverse transfer capacitance		C _{rss}		_	1000	_	
Reverse transfer capacitance Output capacitance		Coss		_	1400	_	
	Rise time	t _r	. , 10 V □ I _D = 9 A	_	25		
Switching time	Turn-ON time	t _{on}	VGS OV J C	- - ±100 - - 10 30 - - 10 - - 1.3 - 2.5 - 3.5 5.5 - 2.1 2.7 24 48 - - 4200 - - 1000 - - 1400 -	_		
Switching time	Fall time	t _f	4.7 D 4.7 D 3 d 1.6 d	_	46	_	- ns
	Turn-OFF time	t _{off}	V _{DD} ≃ 15 V Duty ≦ 1%, t _W = 10 μs	_	120		
Total gate charge (gate-source plus		Qg			113		
Gate-source charge 1		Q _{gs1}	$V_{DD} \simeq 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$	_	13	_	nC
Gate-drain ("mille	er") charge	Q _{gd}		_	42	_	

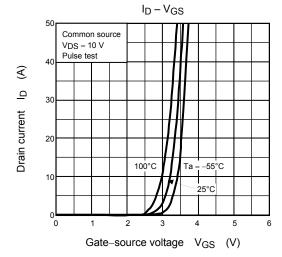
Source-Drain Ratings and Characteristics (Ta = 25°C)

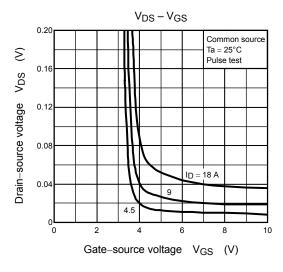
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Drain reverse current	Pulse	(Note 1)	I_{DRP}	_	_	_	72	Α
Forward voltage (diode)			V _{DSF}	I _{DR} = 18 A, V _{GS} = 0 V	_	_	-1.2	V

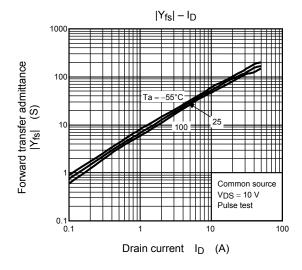
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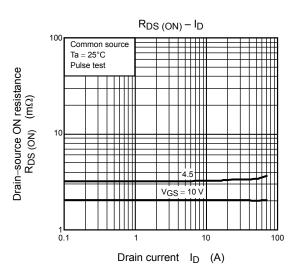


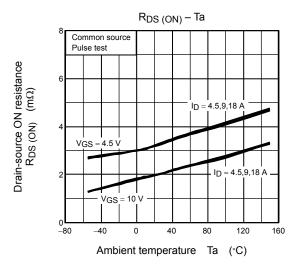


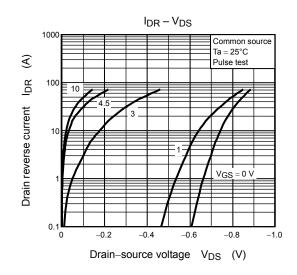


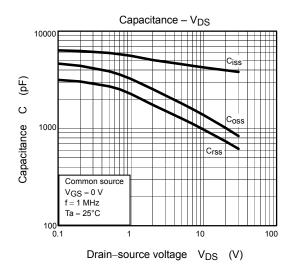


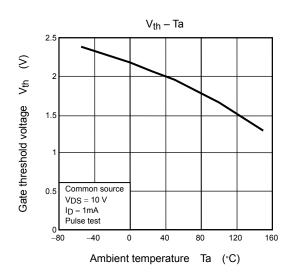


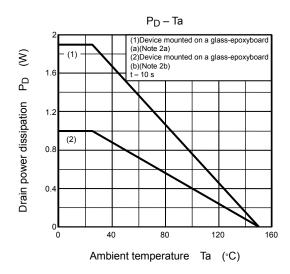


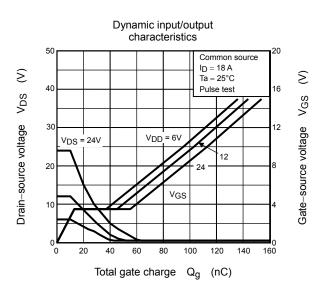


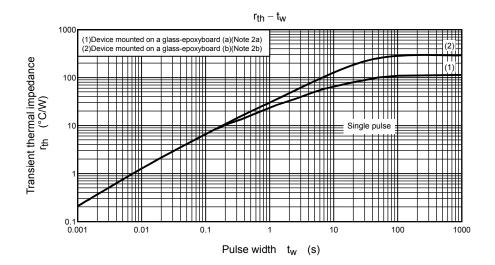


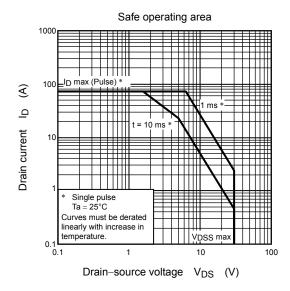












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